Notice of References Cited Application/Control No. 10/656,696 Applicant(s)/Patent Under Reexamination MIN ET AL. Examiner Seokyun Moon Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0137485	07-2003	Wei et al.	345/102
*	В	US-2003/0142118	07-2003	Funamoto et al.	345/691
*	С	US-2002/0057247	05-2002	Lee et al.	345/88
*	D	US-2003/0178951	09-2003	Park et al.	315/312
*	E	US-6,636,190	10-2003	Hirakata et al.	345/74.1
*	F	US-5,844,540	12-1998	Terasaki, Hirohide	345/102
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν				,	
	0					
	Р					
	α					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.